

# 1N5817W

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## 1.0A SURFACE MOUNT SCHOTTKY BARRIER DIODE

### Features:

- Schottky Barrier Chip
- Guard Ring Die Construction for Transient Protection
- Low Power Loss, High Efficiency
- High Surge Capability
- High Current Capability and Low Forward Voltage Drop
- For Use in Low Voltage, High Frequency Inverters, Free Wheeling, and Polarity Protection Application.

### Mechanical Data:

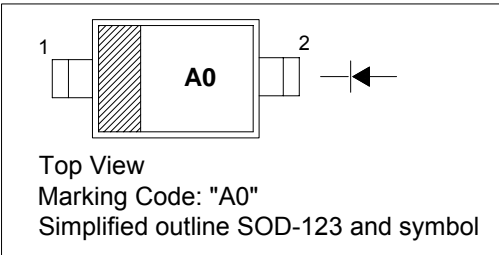
**Case:** SOD-123, Plastic

**Terminals:** Solderable per MIL-STD-202, Method 208

**Polarity:** Cathode Band

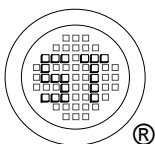
### PINNING

PIN	DESCRIPTION
1	Cathode
2	Anode



### Absolute Maximum Ratings (T<sub>a</sub> = 25°C)

	Symbol	Value	Unit
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	20	V
Working Peak Reverse Voltage at I <sub>R</sub> =1.0mA	V <sub>RWM</sub>	20	V
DC Blocking Voltage	V <sub>R</sub>	20	V
RMS Reverse Voltage	V <sub>R(RMS)</sub>	14	V
Average Rectified Output Current at T <sub>L</sub> =90°C	I <sub>O</sub>	1.0	A
Power Dissipation	P <sub>tot</sub>	450	mW
Non-Repetitive Peak Forward Surge Current 8.3ms single half sine-wave superimposed on rated load (JEDEC Method)	I <sub>FSM</sub>	25	A
Typical Thermal Resistance Junction to Ambient	R <sub>θJA</sub>	222	°C/W
Operating Temperature Range	T <sub>j</sub>	-65 to +125	°C
Storage Temperature Range	T <sub>s</sub>	-65 to +150	°C



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ISO/TS 16949 : 2002  
Certificate No. 05103



ISO 14001:2004  
Certificate No. 7116



ISO 9001:2000  
Certificate No. 0506098

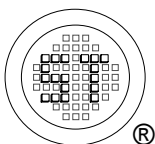
Dated : 24/11/2004

Characteristics at T<sub>amb</sub> = 25°C

		Symbol	Min.	Typ.	Max.	Unit
Forward Voltage (Note 1)	at I <sub>F</sub> = 0.1A	V <sub>FM</sub>	-	-	0.32	V
	at I <sub>F</sub> = 1.0A	V <sub>FM</sub>	-	-	0.45	V
	at I <sub>F</sub> = 3.0A	V <sub>FM</sub>	-	-	0.75	V
Reverse Breakdown Voltage	at I <sub>R</sub> =1.0mA	V <sub>(BR)R</sub>	20	-	-	V
Reverse Leakage Current (Note 1)	at V <sub>R</sub> =20V	I <sub>RM</sub>	-	-	1	mA
	at V <sub>R</sub> =20V, T <sub>A</sub> =100°C		-	-	10	mA
	at V <sub>R</sub> =2V		-	10	50	μA
	at V <sub>R</sub> =2V, T <sub>A</sub> =100°C		-	1	2	mA
	at V <sub>R</sub> =3V		-	15	75	μA
	at V <sub>R</sub> =3V, T <sub>A</sub> =100°C		-	1.5	3	mA
Typical Junction Capacitance at V <sub>R</sub> = 2V, f = 1MHz		C <sub>J</sub>	-	110	-	pF

Notes:

1. Pulse Test: Pulse width ≤ 200 μs, Duty Cycle ≤ 2%.



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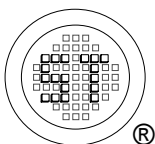
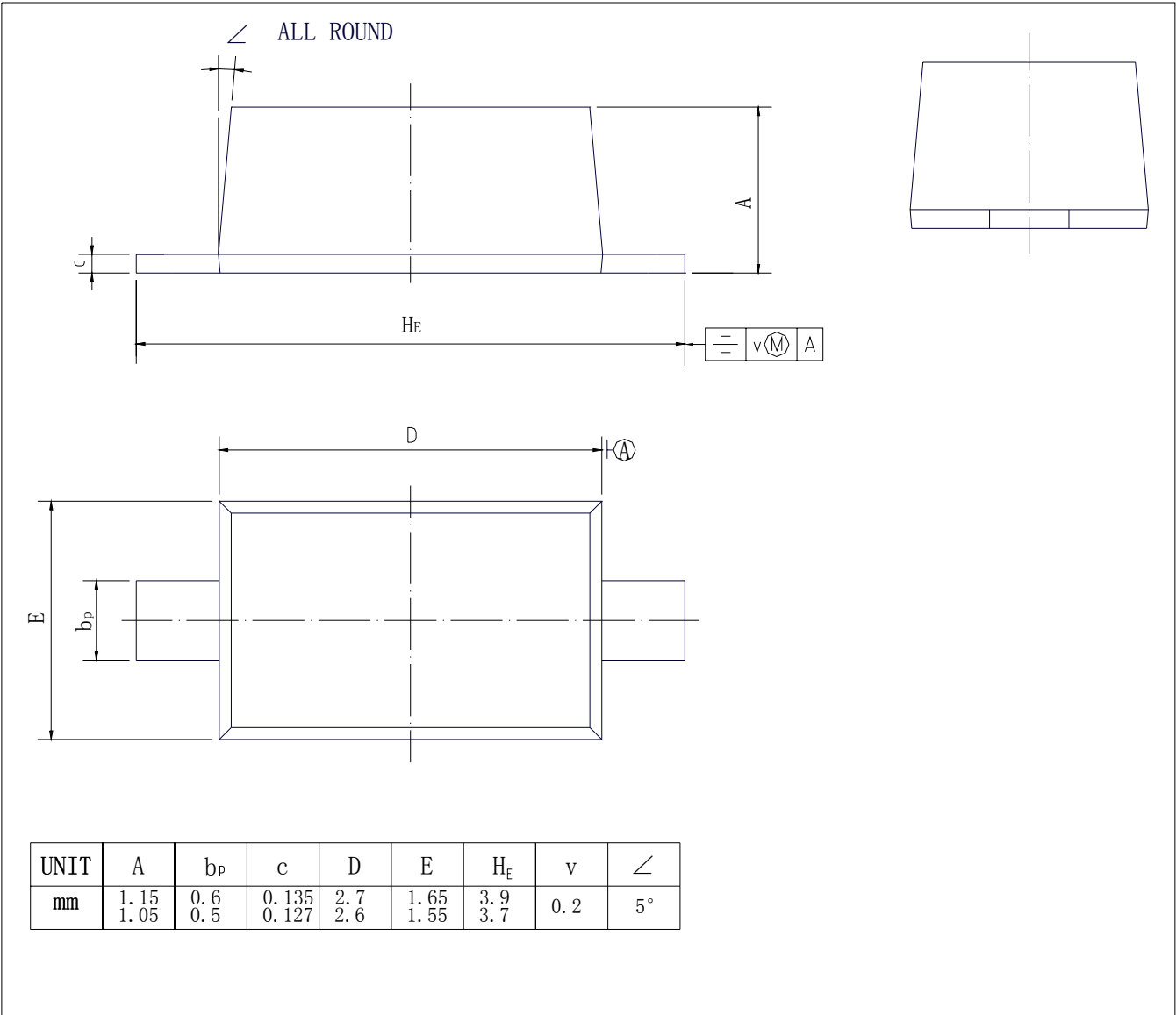


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PACKAGE OUTLINE

Plastic surface mounted package; 2 leads

SOD-123



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